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| Notice of References Cited | Application/Control No. 10/694,290 | Applicant(s)/Patent Under Reexamination KOELLE ET AL. | |
| | Examiner Phillip Nguyen | Art Unit 2828 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,642,070 | 11-2003 | Jiang et al. | 438/22 |
| * | B | US-6,639,931 | 10-2003 | Dowd et al. | 372/96 |
| * | C | US-6,021,146 | 02-2000 | Jiang et al. | 372/50.124 |
| * | D | US-5,557,627 | 09-1996 | Schneider et al. | 372/50.12 |
| * | E | US-5,568,499 | 10-1996 | Lear, Kevin L. | 372/45.01 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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